

Notice of References Cited	Application/Control No. 09/540,012		Applicant(s)/Patent Under Reexamination HAIKIN ET AL.	
	Examiner Madeleine AV Nguyen		Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,257,097 A	10-1993	Pineau et al.	358/500
*	B	US-2002/0154325 A1	10-2002	Holub, Richard A.	358/1.9
*	C	US-5,818,960	10-1998	Gregory et al.	382/167
*	D	US-6,628,822	09-2003	Nakabayashi et al.	382/162
*	E	US-6,873,434 B1	03-2005	Kohler et al.	358/1.9
*	F	US-6,633,668 B1	10-2003	Newman, Todd	382/166
*	G	US-2003/0053683 A1	03-2003	Newman et al.	382/162
*	H	US-6,456,293 B1	09-2002	Grandy, James C.	345/591
*	I	US-2003/0053682 A1	03-2003	HAIKIN et al.	382/162
*	J	US-5,748,858	05-1998	Ohtsuka et al.	358/1.9
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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